

Features

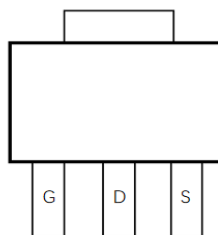
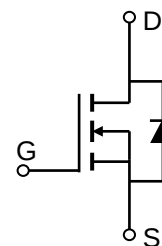
- Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS Tested
- 100% ΔV_{ds} Tested
- Halogen-free; RoHS-compliant
- Pb-free plating

Applications

- Load Switch
- PWM Application
- Power Management

Product Summary

Parameters	Value	Unit
V_{DSS}	60	V
$V_{GS(th_Typ)}$	1.6	V
$I_D(@V_{GS}=10V)$	3	A
$R_{DS(ON_Typ)}(@V_{GS}=10V)$	85.0	mΩ
$R_{DS(ON_Typ)}(@V_{GS}=4.5V)$	95.6	mΩ


SOT-89-3L Top View

Pin Assignment

Schematic Diagram
Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
RSTN2310A	2310A	3	Tape&Reel	SOT-89-3L	1000	40000

Absolute Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-to-Source Voltage	60	V
V_{GS}	Gate-to-Source Voltage	± 20	V
I_D	Continuous Drain Current	$T_C = 25^\circ\text{C}$	A
		$T_C = 100^\circ\text{C}$	
I_{DM}	Pulsed Drain Current ⁽¹⁾	Refer to Fig.4	A
E_{AS}	Single Pulsed Avalanche Energy ⁽²⁾	6	mJ
P_D	Power Dissipation	$T_C = 25^\circ\text{C}$	W
		$T_C = 100^\circ\text{C}$	
T_J, T_{STG}	Junction & Storage Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

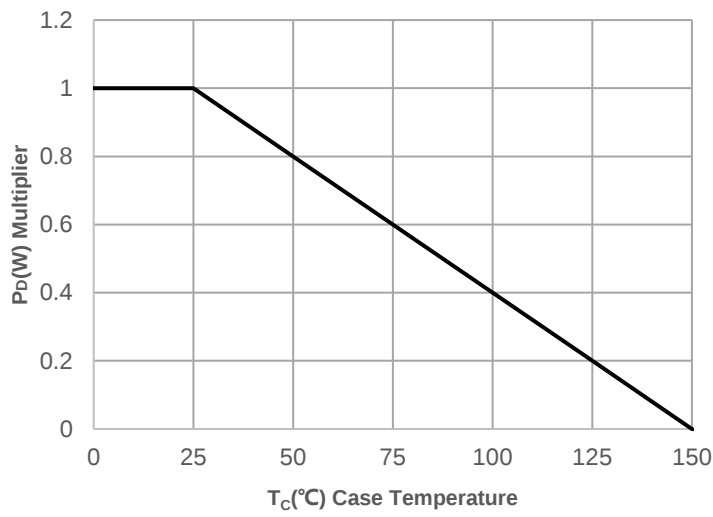
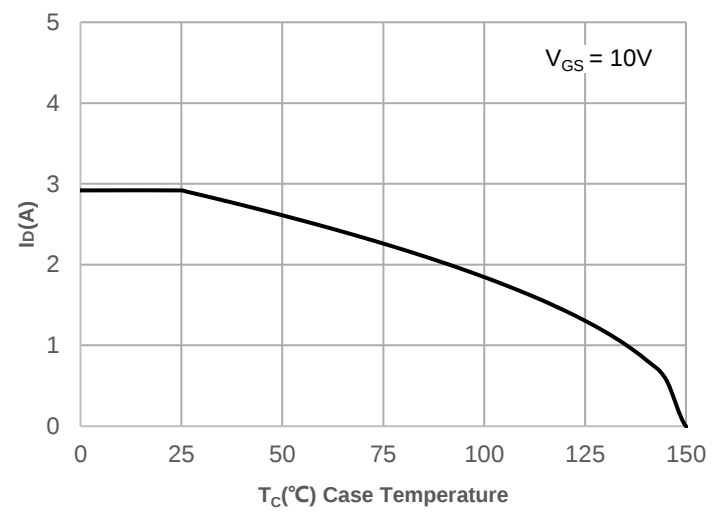
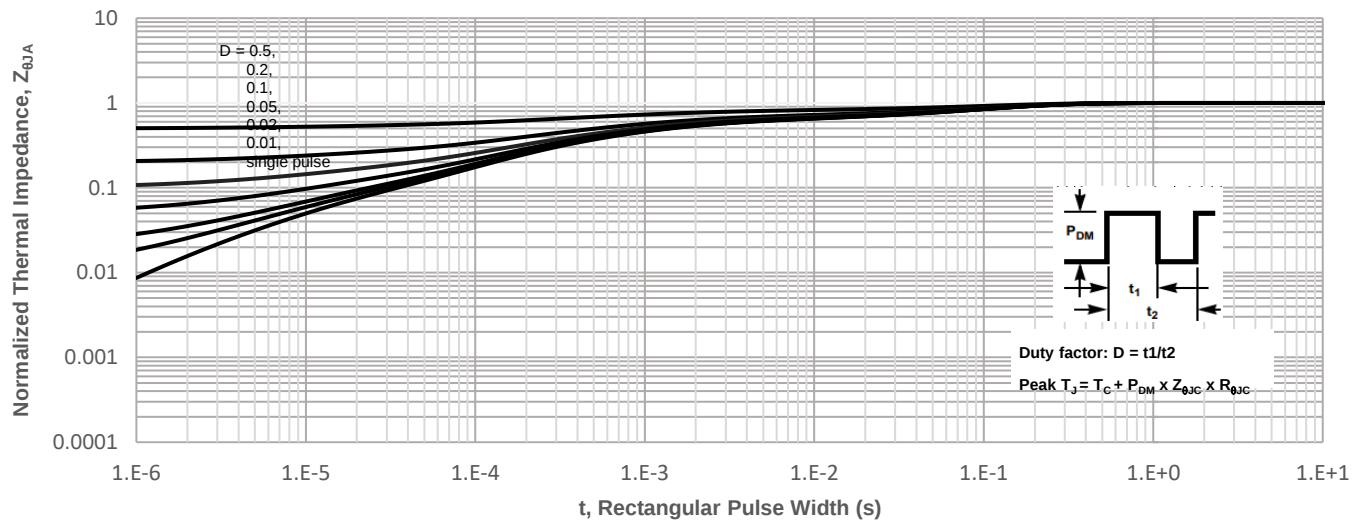
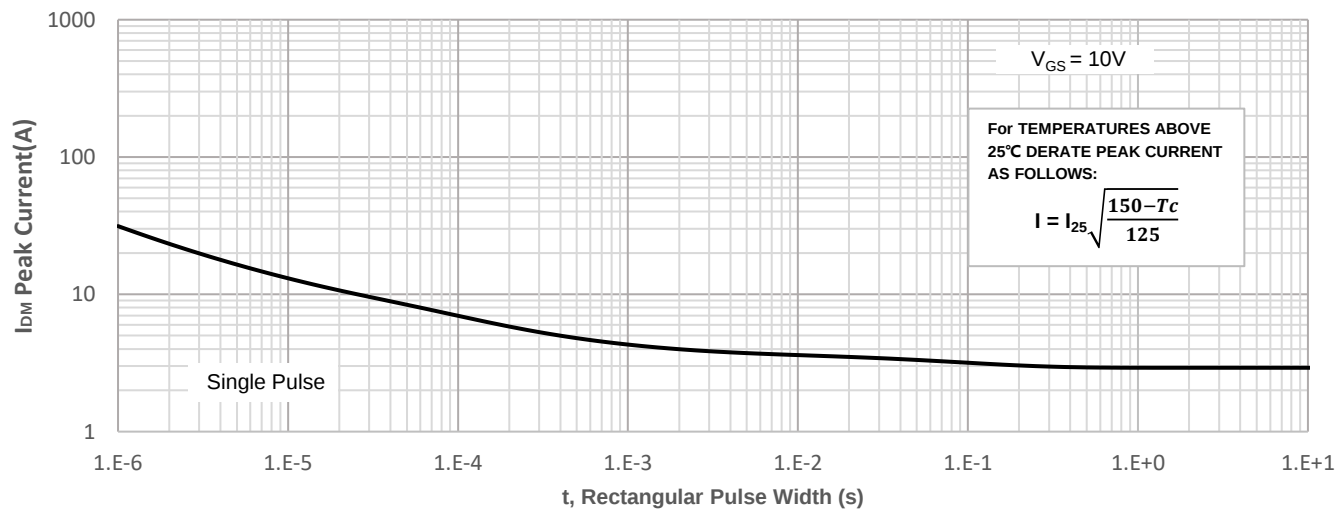
Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	51	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance, Junction to Case	19.3	

Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise specified)

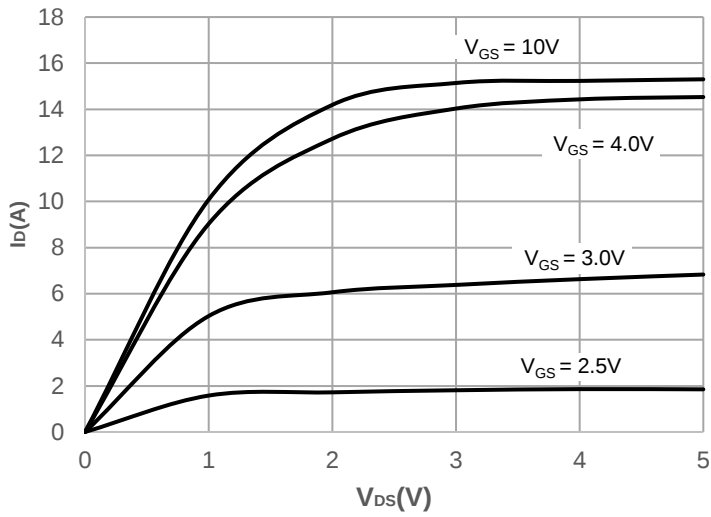
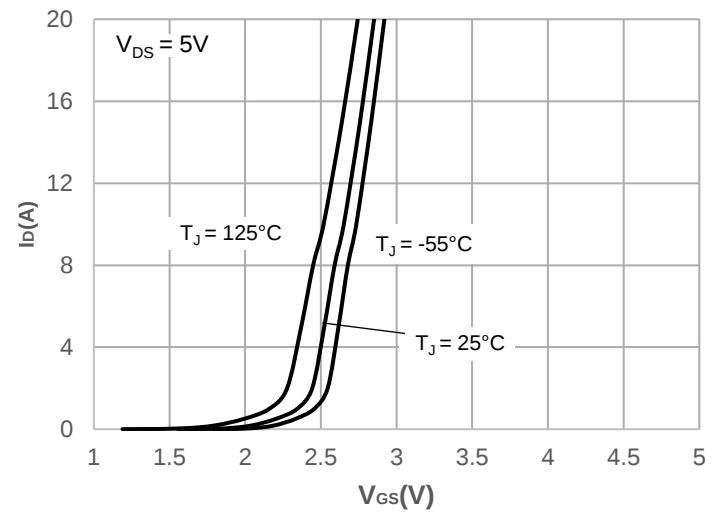
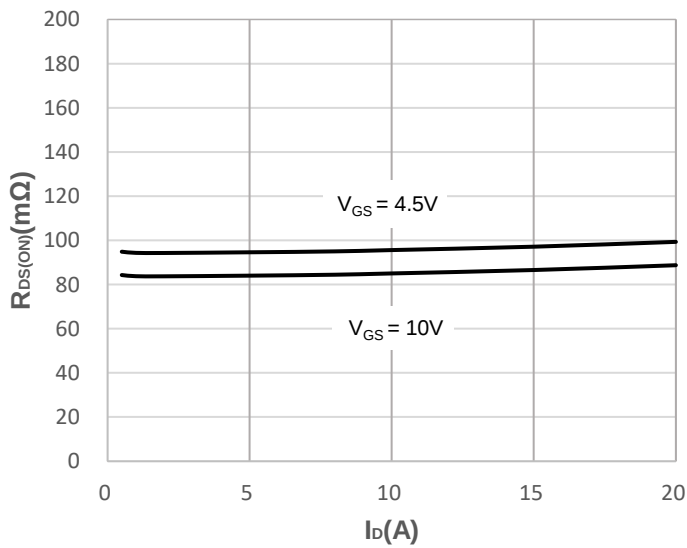
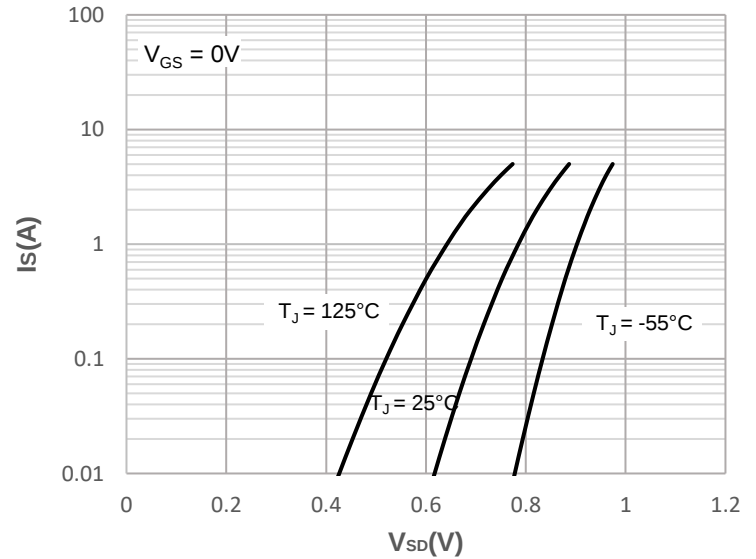
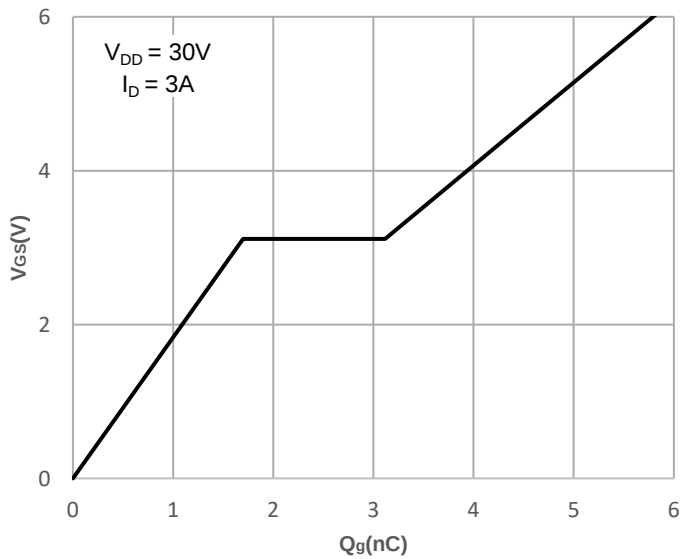
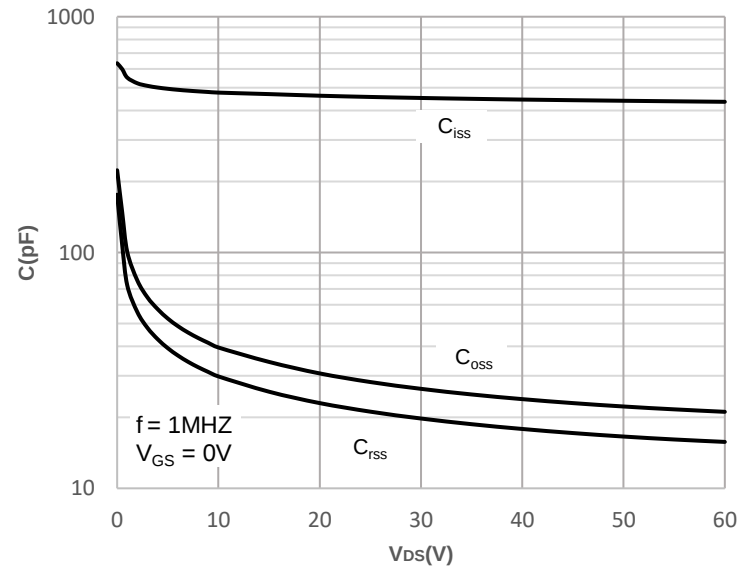
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	I _D = 250μA, V _{GS} = 0V	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60V, V _{GS} = 0V	-	-	1.0	μA
I _{GSS}	Gate-Body Leakage Current	V _{DS} = 0V, V _{GS} = ±20V	-	-	±100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	1.1	1.6	2.2	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	V _{GS} = 10V, I _D = 3A	-	85.0	92.0	mΩ
		V _{GS} = 4.5V, I _D = 2A	-	95.6	119.0	mΩ
Dynamic Characteristics						
R _g	Gate Resistance	f = 1MHz	-	2.5	-	Ω
C _{iss}	Input Capacitance	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz	326	457	617	pF
C _{oss}	Output Capacitance		20	28	38	pF
C _{rss}	Reverse Transfer Capacitance		15	21	29	pF
Q _g	Total Gate Charge	V _{GS} = 0 to 10V V _{DS} = 30V, I _D = 3A		10		nC
Q _{gs}	Gate Source Charge			1.7		nC
Q _{gd}	Gate Drain("Miller") Charge			1.4		nC
Switching Characteristics						
t _{d(on)}	Turn-On DelayTime	V _{GS} = 10V, V _{DD} = 30V I _D = 1.5A, R _{GEN} = 3Ω	-	3.3	-	ns
t _r	Turn-On Rise Time		-	5.2	-	ns
t _{d(off)}	Turn-Off DelayTime		-	14	-	ns
t _f	Turn-Off Fall Time		-	1.6	-	ns
Body Diode Characteristics						
I _S	Maximum Continuous Body Diode Forward Current		-	-	3	A
I _{SM}	Maximum Pulsed Body Diode Forward Current		-	-	12	A
V _{SD}	Body Diode Forward Voltage	V _{GS} = 0V, I _S = 3A	-		1.2	V

- Notes:
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
 2. E_{AS} condition: Starting $T_J = 25^\circ\text{C}$, $V_{DD} = 30\text{V}$, $V_G = 10\text{V}$, $R_G = 25\text{ohm}$, $L = 0.5\text{mH}$, $I_{AS} = 4.9\text{A}$, $V_{DD} = 0\text{V}$ during time in avalanche.
 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch^2 pad of 2oz copper FR4 PCB.
 4. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 0.5\%$.

Typical Performance Characteristics

Figure 1: Power De-rating

Figure 2: Current De-rating

Figure 3: Normalized Maximum Transient Thermal Impedance

Figure 4: Peak Current Capacity


Typical Performance Characteristics

Figure 5: Output Characteristics

Figure 6: Typical Transfer Characteristics

Figure 7: On-resistance vs. Drain Current

Figure 8: Body Diode Characteristics

Figure 9: Gate Charge Characteristics

Figure 10: Capacitance Characteristics


Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

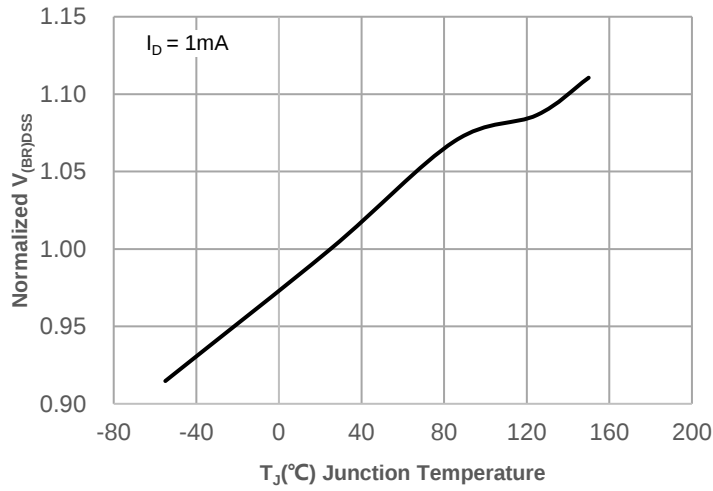


Figure 12: Normalized on Resistance vs. Junction Temperature

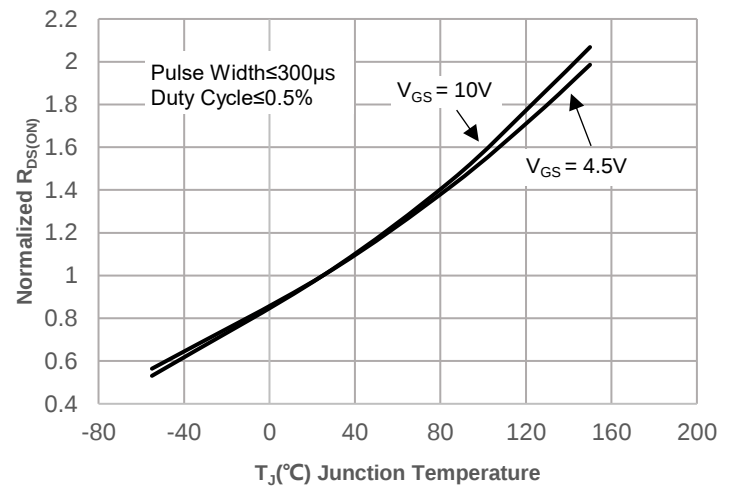


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

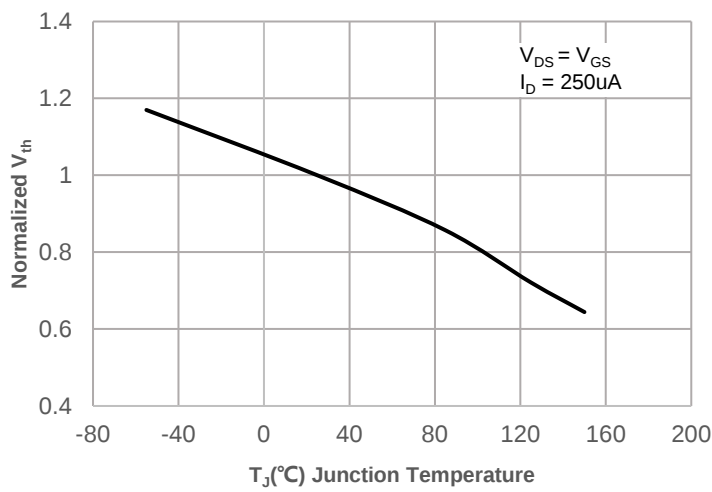


Figure 14: R_DS(on) vs. V_GS

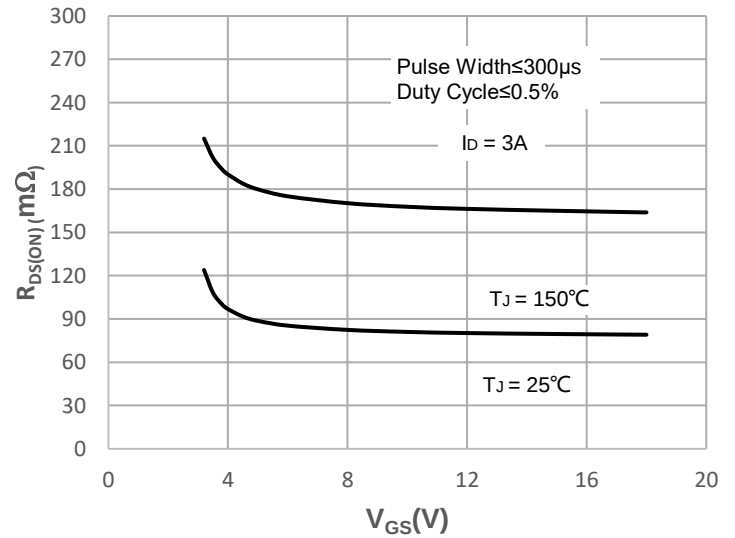
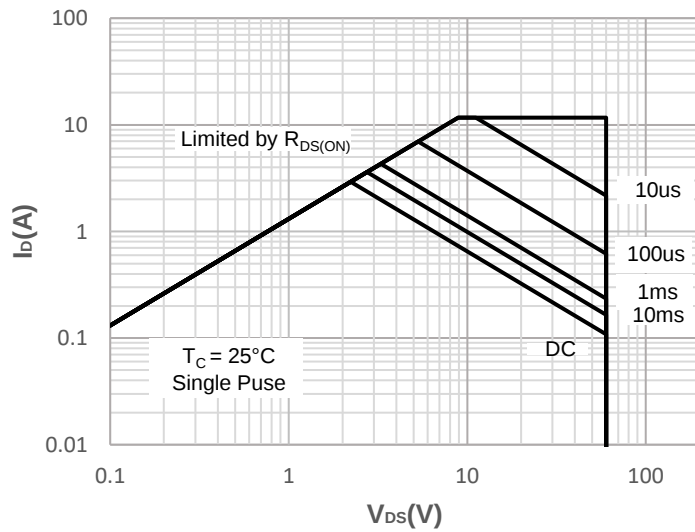


Figure 15: Maximum Safe Operating Area



Test Circuit

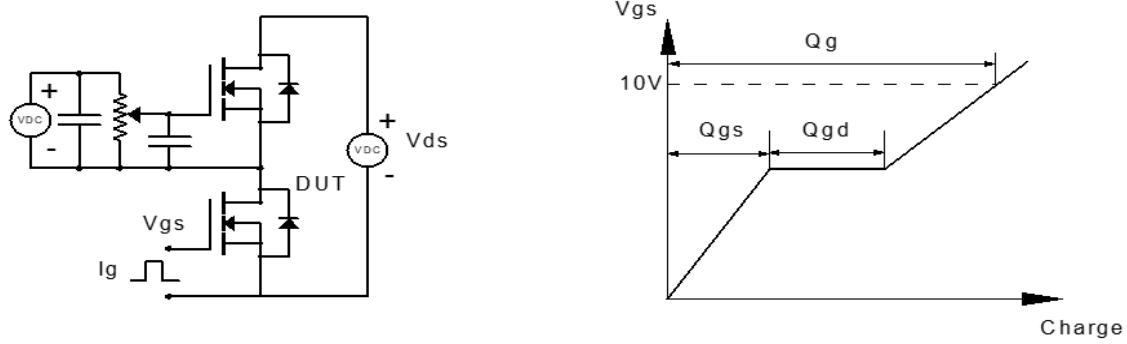


Figure 1: Gate Charge Test Circuit & Waveform

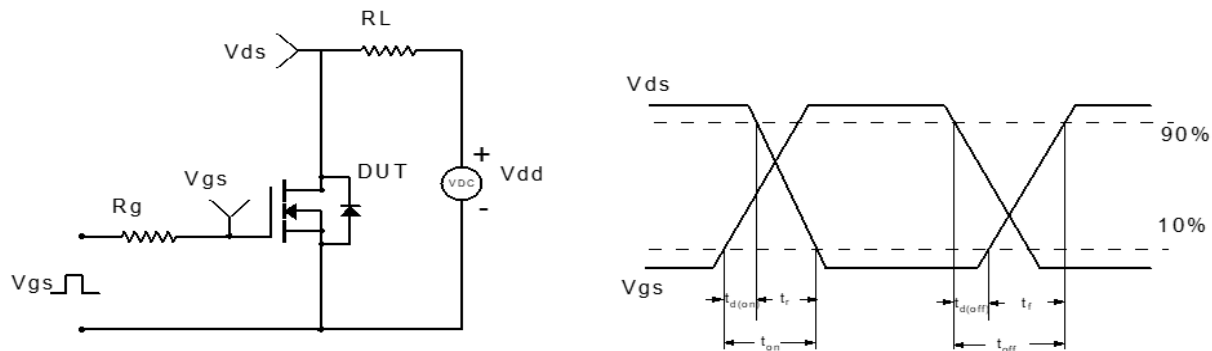


Figure 2: Resistive Switching Test Circuit & Waveform

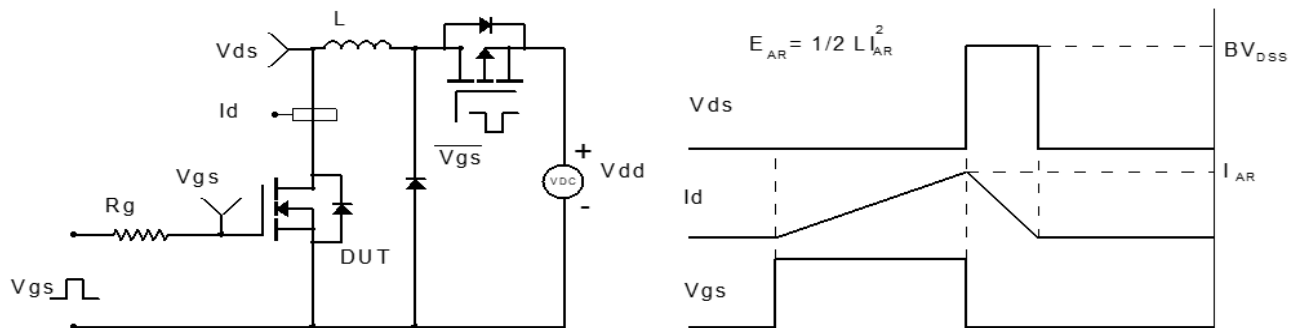


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

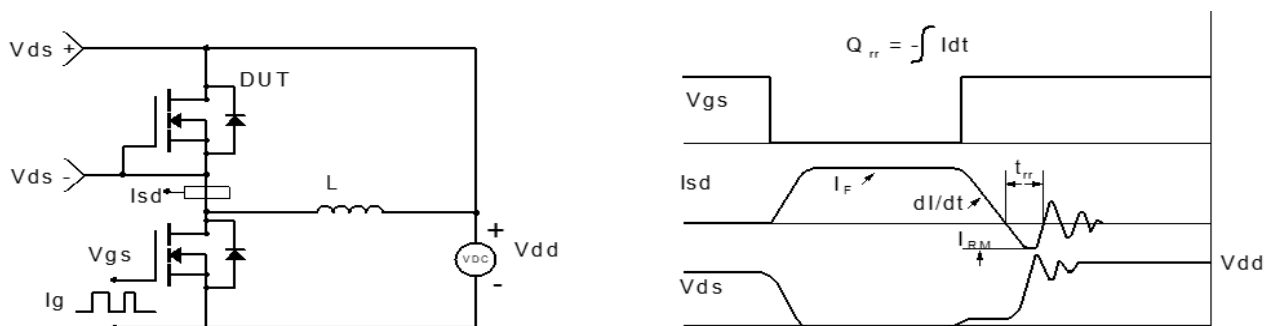
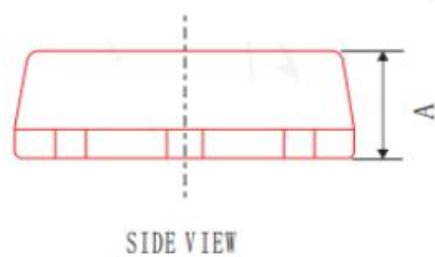
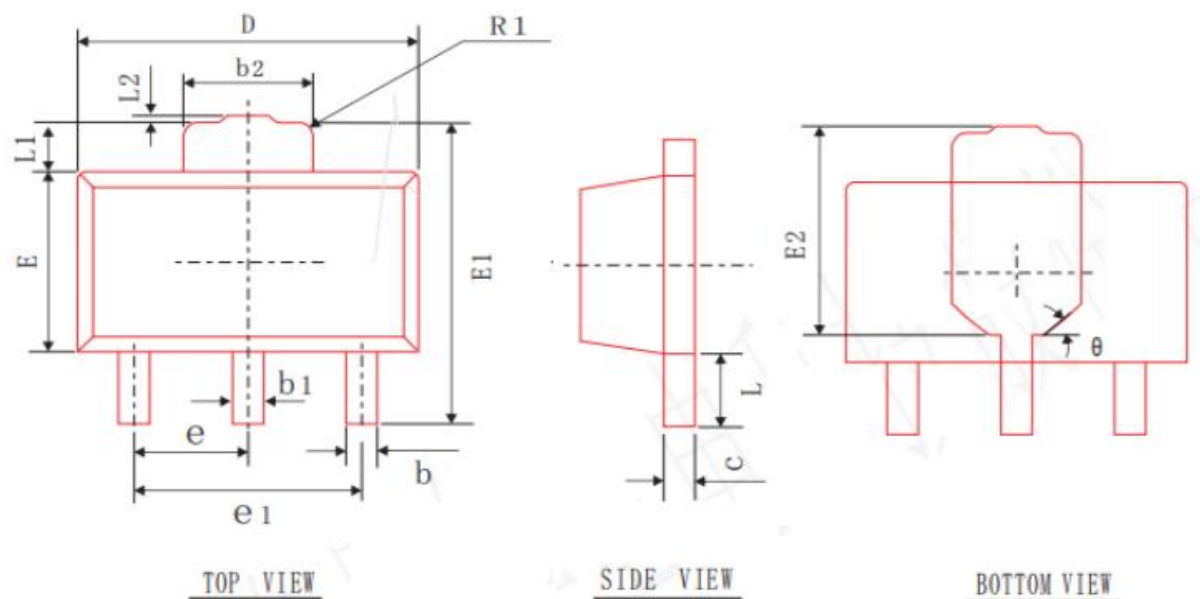


Figure 4: Diode Recovery Test Circuit & Waveform

Package Mechanical Data(SOT-89-3L)



SYMBOL	MIN	NOM	MAX
A	1.40	1.50	1.60
b	0.36	0.40	0.50
b1	0.44	0.48	0.58
b2	1.60	1.70	1.80
c	0.35	0.40	0.45
D	4.40	4.50	4.60
E	2.40	2.50	2.60
E1	4.00	4.20	4.40
E2	2.65	2.85	3.05
e1	2.80	3.00	3.20
L	0.90	1.00	1.10
L1	0.60	0.70	0.80
L2	0.075 REF		
R1	0.2 BSC		
θ	45° TYP		
e	1.5 BSC		